

<b>Notice of References Cited</b>	Application/Control No. 10/659,744	Applicant(s)/Patent Under Reexamination NABEYAMA ET AL.	
	Examiner Kenneth J. Malkowski	Art Unit 2613	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,392,807	05-2002	Barbarossa et al.	359/578
*	B	US-6,081,388	06-2000	Widl, Andreas	359/666
*	C	US-6,807,208	10-2004	Nasu et al.	372/36
*	D	US-2003/0223248	12-2003	Cronin et al.	362/555
*	E	US-6,822,747	11-2004	Li et al.	356/519
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.